onsemi

IGBT Die PCFG50T65SQF

V_{RCE} = 650 V I_C = Limited by T_{j(max)}

Using novel field stop IGBT technology, **onsemi**'s new series of field stop 4th generation IGBTs offer the optimum performance for solar inverter and UPS applications where low conduction and switching losses are essential.

Features

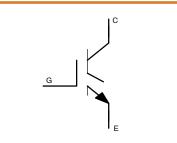
- Maximum Junction Temperature: $T_J = 175^{\circ}C$
- Positive Temperature Co-efficient for Easy Parallel Operating
- High Current Capability
- Low Saturation Voltage: $V_{CE(sat)} = 1.6 V (Typ.) @ I_C = 50 A$
- High Input Impedance
- Fast Switching
- Tighten Parameter Distribution

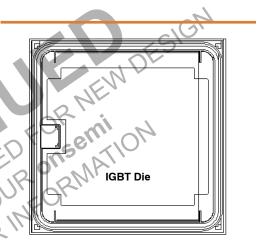
Typical Applications

- Solar Inverters
- UPS Systems

MECHANICAL DATA

Parameter	Mils	μm			
Die Size	153.94 × 153.94	3910 x 3910			
Gate Pad Size	118.9 × 108.58	3020 x 2758			
Emitter Pad Size	14.05 × 17.68	357 x 449.2			
Die Thickness	2.48	63			
Scribe Width	80				
Top Metal	5 µm AlSiCu				
Back Metal	1.05 μm Al/NiV/Ag				
Topside Passivation	Silicon Nitride				
Wafer Diameter	200	mm			
Max Possible Die Per Wafer	R ^L 17	43			
Recommended Storage Environment	In original container, in dry nitrogen, < 3 months at ambient temperature of 23°C				





DIE Outline

ORDERING INFORMATION

Device	Inking?	Shipping Method
PCFG50T65SQF	No	Sawn Wafer on Tape

MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Collector to Emitter Voltage, $T_J = 25^{\circ}C$	V _{CES}	650	V
Gate to Emitter Voltage	V _{GES}	±20	V
Collector Current $@T_C = 25^{\circ}C$	۱ _C	(Note 1)	А
Pulsed Collector Current	I _{CM}	200	А
Operating Junction Temperature	TJ	-40 to +175	°C
Storage Temperature Range	T _{STG}	– 17 to +25	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

1. Depending on the thermal properties of assembly.

2. Not subject to production test - verified by design/characterization.

PCFG50T65SQF

ELECTRICAL CHARACTERISTICS (T_J = 25° C unless otherwise specified)

Parameter	Test Conditions	Symbol	Min	Тур	Max	Unit
OFF CHARACTERISTICS						
Collector-Emitter Breakdown Voltage	V _{GE} = 0 V, I _C = 1 mA	BV _{CES}	650			V
Temperature Coefficient of Breakdown Voltage	I_{C} = 1 mA, reference to 25°C	$\Delta BV_{CES}/\Delta T_{J}$		0.6		V/°C
Collector-Emitter Cutoff Current	V_{GE} = 0 V, V_{CE} = V_{CES}	I _{DSS}			250	μA
Gate Leakage Current	V_{CE} = 0 V, V_{GE} = V_{GES}	I _{GSS}			±400	nA
ON CHARACTERISTICS						

G-E Threshold Voltage	$V_{GE} = V_{CE}$, $I_C = 50 \text{ mA}$	V _{GE(th)}	2.6	4.5	6.4	V
Collector-Emitter Saturation Voltage	I _C = 50 A, V _{GE} = 15 V	V _{CE(sat)}		1.6	2.1	V
	I_{C} = 50 A, V_{GE} = 15 V, T_{C} = 175°C			1.92		V

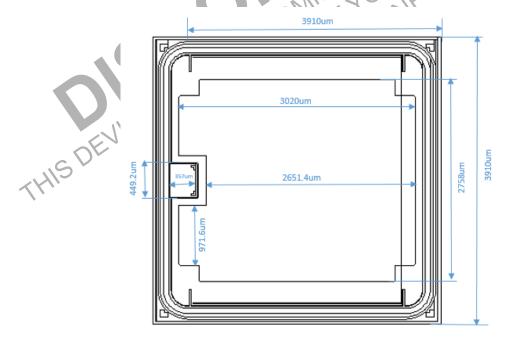
DYNAMIC CHARACTERISTICS

Input Capacitance	V_{GE} = 0 V, V_{CE} = 30 V, f = 1 MHz	C _{ies}		3275	JO'	рF
Output Capacitance		Coes		84	0	
Reverse Transfer Capacitance		C _{res}		12		
GATE CHARGE CHARACTERISTICS			N.S.	4		

Total Gate Charge V_{CE} = 400 V, I_C = 50 A, V_{GE} = 15 V Q_g 99 nC Gate to Emitter Charge Qge 17 23 23 17

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

3. For ordering, technique and other information on onsemi automotive bare die products, please contact automotivebaredie@onsemi.com.



(all dimensions in μm) Figure 1. Die Layout

Further Electrical Characteristic

Switching characteristics and thermal properties are depending strongly on module design and mounting technology and can therefore not be specified for a bare die.

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